

Search Notes



Application/Control No.

09/593,761

Examiner

Hanh Phan

Applicant(s)/Patent under Reexamination

YANO, YUTAKA

Art Unit

2613

SEARCHED

Class	Subclass	Date	Examiner
398	79	07/08/06	HP
	31,202		
	33,188		
	34,183		
	182,192		
	140,193		
	141,154		
	91		
	47		
	53		
	102		
	161		
	158		
	159		

update search 07/08/06 HP

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
398	79,31,33	07/08/06	HP
	188,202		
	182,183		
	34,192		
	193,140		
	141,154		
	91,47		
	53,102		
	161,158		
	159		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Fast Search see attached printout in the file.	07/08/06	HP
IEEE search.		
JPO search.		
PGPUB text search see interference search printout	07/08/06	HP